SCOPE:

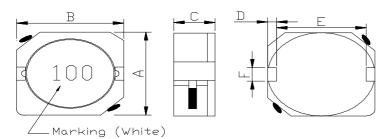
This specification applies to the Pb Free high current type SMD inductors for MSCDRI-105R-SERIES

PRODUCT INDENTIFICATION

MSCDRI - 105R - 100 M

- 1
- 2
- 3 4
- 1 Product Code
- 2 Dimensions Code
- **3 Inductance Code**
- **4** Tolerance Code

(1) SHAPES AND DIMENSIONS



A: 10.0±0.5 mm

B: 10.1±0.5 mm

C: 5.10 Max. mm

D: 1.20 Typ. mm

E: 7.70 Typ. mm

F: 3.00 Typ. mm

(2) ELECTRICAL SPECIFICATIONS SEE TABLE 1

TEST INSTRUMENTS

L : HP 4284A PRECISION LCR METER (or equivalent)

RDC: CHROMA MODEL 16502 MILLIOHMMETER (or equivalent)

(3) CHARACTERISTICS

- (3)-1 Ambient temperature +60°C Max.
- (3)-2 Operate temperature range -40° C $\sim +125^{\circ}$ C (Including self temp. rise)
- (3)-3 Storage temperature range $-40^{\circ}\text{C} \sim +125^{\circ}\text{C}$



TABLE 1

MAGLAYERS	Inductance	Percent	Test	Resistance	Rated D	C Current	
PT/NO.	L(µH)	Tolerance	Frequency	RDC(Ω)Max.	IDC1(A)	IDC2(A)	Marking
MSCDRI-105R-1R5	1.5	N	100kHz/0.25V	5.8m	10.5	8.30	1R5
MSCDRI-105R-2R2	2.2	M,N	100kHz/0.25V	7.2m	9.25	7.50	2R2
MSCDRI-105R-3R3	3.3	N	100kHz/0.25V	10.4m	7.80	6.50	3R3
MSCDRI-105R-4R7	4.7	M,N	100kHz/0.25V	12.3m	6.40	6.10	4R7
MSCDRI-105R-6R8	6.8	N	100kHz/0.25V	18m	5.40	5.40	6R8
MSCDRI-105R-8R2	8.2	M,N	100kHz/0.25V	20m	4.85	5.00	8R2
MSCDRI-105R-100	10	M,N	100kHz/0.25V	26m	4.45	4.50	100
MSCDRI-105R-120	12	M,N	100kHz/0.25V	33m	4.00	3.80	120
MSCDRI-105R-150	15	M,N	100kHz/0.25V	41m	3.60	3.40	150
MSCDRI-105R-180	18	M,N	100kHz/0.25V	46m	3.20	3.10	180
MSCDRI-105R-220	22	M,N	100kHz/0.25V	61m	2.95	2.90	220
MSCDRI-105R-270□	27	M,N	100kHz/0.25V	69m	2.70	2.60	270
MSCDRI-105R-330□	33	M,N	100kHz/0.25V	84m	2.40	2.50	330
MSCDRI-105R-390□	39	M,N	100kHz/0.25V	0.106	2.30	2.25	390
MSCDRI-105R-470□	47	M,N	100kHz/0.25V	0.130	2.00	2.00	470
MSCDRI-105R-560□	56	M,N	100kHz/0.25V	0.149	1.90	1.90	560
MSCDRI-105R-680□	68	M,N	100kHz/0.25V	0.201	1.65	1.60	680
MSCDRI-105R-820□	82	M,N	100kHz/0.25V	0.227	1.50	1.45	820
MSCDRI-105R-101□	100	K,M	100kHz/0.25V	0.253	1.35	1.35	101
MSCDRI-105R-121□	120	K,M	100kHz/0.25V	0.303	1.28	1.18	121
MSCDRI-105R-151□	150	K,M,N	100kHz/0.25V	0.370	1.12	1.10	151
MSCDRI-105R-181□	180	K,M	100kHz/0.25V	0.419	1.04	1.00	181
MSCDRI-105R-221□	220	K,M	100kHz/0.25V	0.500	0.94	0.94	221
MSCDRI-105R-271□	270	K,M	100kHz/0.25V	0.672	0.84	0.80	271
MSCDRI-105R-331	330	K,M	100kHz/0.25V	0.812	0.75	0.73	331
MSCDRI-105R-391□	390	K,M	100kHz/0.25V	0.953	0.70	0.70	391
MSCDRI-105R-471	470	K,M	100kHz/0.25V	1.289	0.60	0.54	471
MSCDRI-105R-561	560	K,M	100kHz/0.25V	1.430	0.54	0.52	561
MSCDRI-105R-681□	680	K,M	100kHz/0.25V	1.599	0.52	0.51	681
MSCDRI-105R-821□	820	K,M	100kHz/0.25V	1.768	0.50	0.48	821
MSCDRI-105R-102	1000	K,M	100kHz/0.25V	1.989	0.48	0.42	102

※ ☐ specify the inductance tolerance,K(±10%),M(±20%),N(±30%)

% IDC1 : Based on inductance change (△L/Lo : \leq drop 35%) @ambient temperature 25°C

IDC2 : Based on temperature rise ($\triangle T$: 40°C TYP.)

Rated DC Current: The less value which is IDC1 or IDC2.



(4) RELIABILITY TEST METHOD

MECHANICAL

TEST ITEM	SPECIFICATION	TEST DETAILS
Substrate bending	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board
		in figure 1 and a load applied unitil the figure in the arrow
	There shall be	direction is made approximately 3mm.(keep time 30 seconds)
	no mechanical	PCB dimension shall the page 7/9
	damage or elec-	F(Pressurization)
	trical damege.	Л
		R5 45±2 45±2 10 20 R340
		PRESSURE ROD figure-1
Vibration	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board
		and when a vibration having an amplitude of 1.52mm
	There shall be	and a frequency of from 10 to 55Hz/1 minute repeated should
	no mechanical	be applied to the 3 directions (X,Y,Z) for 2 hours each.
	damage.	(A total of 6 hours)
Solderability	New solder	Flux (rosin, isopropyl alcohol{JIS-K-1522}) shall be coated
	More than 90%	over the whole of the sample before hard, the sample shall
		then be preheated for about 2 minutes in a temperature of
		130∼150℃ and after it has been immersed to a depth 0.5mm
		below for 3±0.2 seconds fully in molten solder M705 with
		a temperature of 245±5℃.
		More than 90% of the electrode sections shall be couered
		with new solder smoothly when the sample is taken out of
		the solder bath.



MECHANICAL

SPECIFICATION		
There shall be no damage or problems.	Temperature profile of reflow soldering soldering (Peak temperature 260±3°C 10 sec Pre-heating Slow cooling (Stored at room temperature) The specimen shall be passed through the reflow oven with the condition shown in the above profile for 1 time. The specimen shall be stored at standard atmospheric conditions for 1 hour, after which the measurement shall be made.	
	no damage or	

ELECTRICAL

TEST ITEM	SPECIFICATION	TEST DETAILS
Insulation	There shall be	DC 100V voltage shall be applied across this sample of top
resistance	no other	surface and the terminal.
	damage or	The insulation resistance shall be more than $1 \times 10^8 \Omega$.
	problems.	
Dielectric	There shall be	AC 100V voltage shall be applied for 1 minute acrosset the top
withstand	no other	surface and the terminal of this sample
voltage	damage or	
	problems.	
Temperature	∆L/L20°C ≦±10%	The test shall be performed after the sample has stabilized in
characteristics	0~2000 ppm/°C	an ambient temperature of -20 to +85 $^{\circ}\!\!\mathrm{C}$,and the value
		calculated based on the value applicable in a normal
		temperature and narmal humidity shall be △L/L20℃ ≦±10%.



ENVIROMENT CHARACTERISTICS

TEST ITEM			SPECIFICATION			
High temperature	∆L/Lo≦±5%	The sample shall be left for 96±4 hours in an atmospere with				
storage		a temperature of 85±2°C and a normal humidity. Upon completion of the measurement shall be made after the sample has been left in a normal temperature and normal humidity for 1 hour.				
	There shall be					
	no mechanical					
	damage.					
Low temperature	∆L/Lo≦±5%	The sample shall be left for 96±4 hours in an atmosphere with				
storage		a temperature of -25±3℃.				
	There shall be	Upon completion of the test, the measurement shall be made				
	no mechanical	after the sample	after the sample has been left in a normal temperature and			
	damage.	normal humidity	normal humidity for 1 hour.			
Change of	∆L/Lo≦±5%	The sample shall be subject to 5 continuos cycles, then it shall be				
temperature		subjected to standard atmospheric conditions for 1 hour,				
	There shall be	after which measurement shall be made.				
	no other dama-					
	ge of problems					
		table 2				
			Temperature	Duration		
		1	−25±3 °C	30 min.		
			(Themostat No.1)			
		2	Standard	No.4 - No.2		
			atmospheric	No.1→No.2		
		3	85±2℃	30 min.		
			(Themostat No.2)	30		
		4	Standard	No 2 - No 4		
			atmospheric	No.2→No.1		
Moisture storage	∆L/Lo≦±5%	The sample shall be left for 96±4 hours in a temperature of				
		40±2℃ and a humidity(RH) of 90∼95%.				
	There shall be	Upon completion of the test, the measurement shall be made				
	no mechanical	after the sample has been left in a normal temperature and				
	damage.	1	y more than 1 hour.			

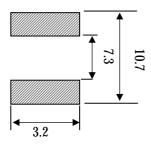


(5) LAND DIMENSION (Ref.)

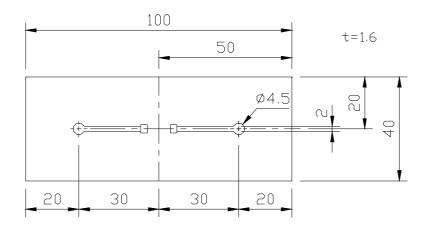
PCB: GLASS EPOXY t=1.6mm

(5)-1 LAND PATTERN DIMENSIONS

(STANDARD PATTERN) Unit:mm



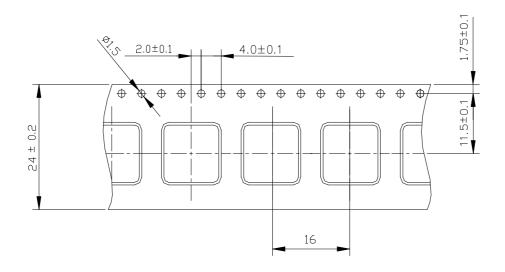
(5)-2 SUBSTRATE BENDING TEST BENDING TEST BOARD



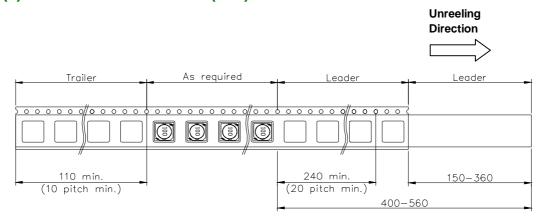


(6) PACKAGING

(6)-1 CARRIER TAPE DIMENSIONS (mm)

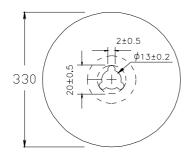


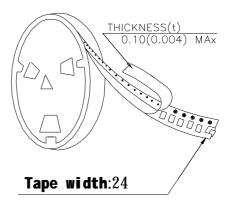
(6)-2 TAPING DIMENSIONS (mm)





(6)-3 REEL DIMENSIONS (mm)





(6)-4 QUANTITY

700pcs/Reel

The products are packaged so that no damage will be sustained.



单击下面可查看定价,库存,交付和生命周期等信息

>>MAG. LAYERS